

MRS BULLETIN

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ON THE COVER: Tuning individual note sections of a Caribbean steel pan is a delicate operation. Several overtones must be tuned to a harmonic relationship with the fundamental frequency. The operation involves selective hammering in different areas of each tone section. This photograph shows Ellie Manette, artist in residence at West Virginia University, working on a pan. For details, see the article, "The Caribbean Steel Pan: Tuning and Mode Studies," by U.J. Hansen, T.D. Rossing, E. Manette, and K. George on p. 44. Photograph by Bob Beverly, WVU Photo Services.

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The Materials Research Society (MRS), a non-profit scientific association founded in 1973, promotes interdisciplinary goal-oriented basic research on materials of technological importance. Membership in the Society includes nearly 11,600 scientists, engineers, and research managers from industrial, government, and university research laboratories in the United States and nearly 50 countries.

The Society's interdisciplinary approach differs from that of single-discipline professional societies because it promotes information exchange across the many technical fields touching materials development. MRS sponsors two major international annual meetings encompassing approximately 50 topical symposia, and also sponsors numerous single-topic scientific meetings. The Society recognizes professional and technical excellence, conducts short courses, and fosters technical interaction in local geographic regions through Sections and University Chapters.

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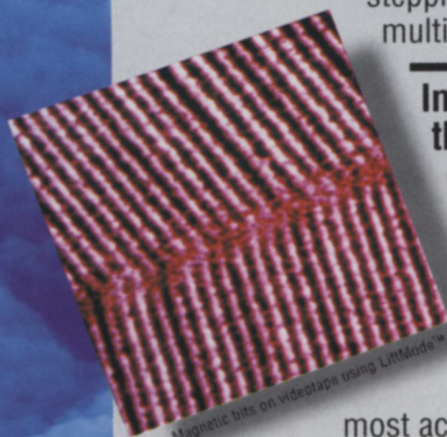
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